

Search Notes

Application/Control No.

09/728,442

Examiner

Djenane M. Bayard

Applicant(s)/Patent under
Reexamination

LEMLER ET AL.

Art Unit

2141

SEARCHED

Class	Subclass	Date	Examiner
709	223	1/31/2008	DB
709	224	1/31/2008	DB
709	220	1/31/2008	DB
715	762	1/31/2008	DB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
709	223/224	1/31/2008	DB
709	220	1/31/2008	DB
715	762	1/31/2008	db

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	1/31/2008	DB
Consulted with W. Vaughn	1/31/2008	DB
Double Patenting search	1/31/2008	DB